- Inputs are TTL-Voltage Compatible
- 8 Latches in a Single Package
- High-Current 3-State Inverting Outputs Can Drive Up to 15 LSTTL Loads
- **Full Parallel Access for Loading**
- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas Instruments Quality and Reliability

### description

These 8-bit latches feature three-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The eight latches of the 'HCT533 are transparent D-type latches. While the enable (C) is high, the  $\overline{\mathbf{Q}}$  outputs will follow the complements of the D inputs. When the enable is taken low, the  $\overline{\Omega}$  outputs will be latched at the inverses of the levels that were set up at the D inputs. The 'HCT533 is functionally equivalent to the 'HCT373 except for having inverted outputs.

An output-control  $(\overline{OC})$  input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or a highimpedance state. In the high-impedance state the outputs neither load nor drive the bus lines significantly. The high-impedance third state and increased drive provide the capability to drive the bus lines in a bus-organized system without need for interface or pull-up components.

The output control does not affect the internal operation of the latches. Old data can be retained or new data can be entered while the outputs are off.

The SN54HCT533 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74HCT533 is characterized for operation from -40°C to 85°C.

SN54HCT533, SN74HCT533 OCTAL D-TYPE TRANSPARENT LATCHES WITH 3-STATE OUTPUTS D2804, MARCH 1984-REVISED SEPTEMBER 1987

SN54HCT533 ... J PACKAGE SN74HCT533 . . . DW OR N PACKAGE

## (TOP VIEW)

	ſ٦	U20∐ VCC
1 <u>a</u> [	2	19 🛛 8a
1D [	3	18 🗍 8D
2D [	]4	17 🗍 7 D
20 [	5	16 70
3 <u>a</u> [	6	15 <b>6</b> 0
3D [	7	14 <b>∏</b> 6D
4D [	8	13 🗍 5D
4ā [	9	12 <b>]</b> 5ā
GND [	10	) 11∐C

SN54HCT533 . . . FK PACKAGE (TOP VIEW)



#### FUNCTION TABLE (EACH LATCH)

	INPUTS		OUTPUT
<u>oc</u>	ENABLE C	D	δ
L	Н	Н	L
L	н	L	н
Ĺ	L	х	āo
н	x	x	Z

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# SN54HCT533, SN74HCT533 OCTAL D-TYPE TRANSPARENT LATCHES WITH 3-STATE OUTPUTS

logic symbol<sup>†</sup>



<sup>†</sup>This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





## SN54HCT533, SN74HCT533 OCTAL D-TYPE TRANSPARENT LATCHES WITH 3-STATE OUTPUTS

## absolute maximum ratings over operating free-air temperature range<sup>†</sup>

Supply voltage range, VCC	
Input clamp current, $I_{K}$ (V <sub>1</sub> < 0 or V <sub>1</sub> > V <sub>CC</sub> ) ± 20 mA	
Output clamp current, $I_{OK}$ (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> ) ± 20 mA	
Continuous output current, IQ (VQ = 0 to VCC) $\dots \dots \dots$	
Continuous current through VCC or GND pins ±70 mA	
Lead temperature 1,6 mm (1/16 in) from case for 60 s: FK or J package	
Lead temperature 1,6 mm (1/16 in) from case for 10 s; DW or N package	
Storage temperature range	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

			SN	54HCT	533	SN	74HCT	533	UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	5.5	4.5	5	5.5	v
VIH	High-level input voltage	$V_{CC} = 4.5 V$ to 5.5 V	2			2			v
ViL	Low-level input voltage	$V_{CC} = 4.5 V \text{ to } 5.5 V$	0		0.8	0		0.8	V
٧I	Input voltage		0		Vcc	0	_	V <u>cc</u>	~
٧o	Output voltage		0		Vcc	0	_	Vcc	v
tt	Input transition (rise and fall) times		0		500	0		500	ns
TA	Operating free-air temperature		- 55		125	- 40		85	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		T <sub>A</sub> - 25°C		SN54HCT533	SN74HCT533	UNIT
PARAMETER	TEST CONDITIONS	Vcc	MIN TYP	MAX	MIN MAX	MIN MAX	UNIT
Main	$V_{I} = V_{IH}$ or $V_{IL}$ , $I_{OH} = -20 \mu A$	4.5 V	4.4 4.499		4.4	4.4	
∨он	$V_{I} = V_{IH} \text{ or } V_{IL}, I_{OH} = -6 \text{ mA}$	4.5 V	3.98 4.30		3.7	3.84	۷
Vai	$V_{I} = V_{IH} \text{ or } V_{IL}, I_{OH} = 20 \mu\text{A}$	4.5 V	0.001	0.1	0.1	0.1	
VOL	$V_{I} = V_{IH} \text{ or } V_{IL}, IOL = 6 \text{ mA}$	4.5 V	0.17	0.26	0.4	0.33	•
lį –	$V_{I} = V_{CC} \text{ or } 0$	5.5 V	±0.1	±100	± 1000	± 1000	nA
loz	VO = VCC or 0, VI = VIH or VIL	5.5 V	±0.01	±0.5	± 10	±5	μA
lcc	$V_{I} = V_{CC} \text{ or } 0, I_{O} = 0$	5,5 V		8	160	80	μΑ
∆I <sub>CC</sub>	One input at 0.5 V or 2.4 V Other inputs at 0 V or V <sub>CC</sub>	5.5 V	1.4	2.4	3	2.9	mA
Cį		4.5 to 5.5 V	3	10	10	10	pF



## SN54HCT533, SN74HCT533 OCTAL D-TYPE TRANSPARENT LATCHES WITH 3-STATE OUTPUTS

			T <sub>A</sub> = 25°C		SN54HCT533		SN74HCT533			
		Vcc	MIN	MAX	MIN	MAX	MIN	MAX	UNIT	
	4.5 V	20		30		25				
tw	v Pulse duration, enable C high	5.5 V	17		27		23		ns	
	Setup time, data before	4.5 V	10		15		13			
su	enable Cł	5.5 V	9		14		12	1		
	4.5 V	5		5		5				
th	Hold time, data after enable C4	5.5 V	5		5		5		ns	

## timing requirements over recommended operating free-air temperature range (unless otherwise noted)

# switching characteristics over recommended operating free-air temperature range (unless otherwise noted), $C_L = 50 \text{ pF}$ (see Note 1)

PARAMETER	FROM	TO		$T_A = 25 ^{\circ}C$			SN54H	ют533	SN74HCT533		UNIT	
FARAMETER	(INPUT)	(OUTPUT)	Vcc	MIN	ТҮР	MAX	MIN	MAX	MIN	MAX	UNIT	
	_	۵	4.5 V		38	35		53	Γ	44		
tpd	D	u u	5.5 V		24	32		48		40	ns	
	~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~	4	4.5 V	1	30	35		53	Γ	44	ns	
<sup>t</sup> pd	С	Any Q	5.5 V		28	32	1	48		40	115	
	50	Αηγ Ω	4.5 V	-	29	35		53		44	ns	
ten	00		Any Q	5.5 V		25	32	}	48		40	115
	00	4	4.5 V		25	35	[	53		44	ns	
<sup>t</sup> dis	UC UC	Any Q	5.5 V		24	32		48		40	13	
		4	4.5 V		10	12	1	18		15	-	
t		Αηγ Ω	5.5 V		9	11	 	16		14	ns	
Cpd	Power dis	sipation capacitan	ce per latch		No load	d, Τ <sub>Δ</sub> =	25°C		5	0 pF typ		

# switching characteristics over recommended operating free-air temperature range (unless otherwise noted), $C_L = 150 \text{ pF}$ (see Note 1)

PARAMETER (INPUT)	FROM	TO		Tr	<b>x</b> = 25	°C	SN54	ICT533	SN74H	ICT533	UNIT	
	(INPUT)	UT) (OUTPUT)	Vcc	MIN	ΤΥΡ	MAX	MIN	MAX	MIN	MAX	UNIT	
tod D	ā	4.5 V		36	52	1	79		65			
<sup>t</sup> pd		u	5.5 V		32	47		71		59	ns	
• .	C Any C	A 0	4.5 V		40	52	1	79		65	Í	
<sup>t</sup> pd		Αηγ Ο		5.5 V		38	47		71		59	កន
	 <u>oc</u>	Any 🖸	4.5 V		35	52		79		65		
ten		Any L	5.5 V		29	47		71		59	ns	
		Απγ α	4.5 V		18	42	1	63		53		
t			5.5 V		16	38	Í	57		48	ns	

Note 1: Load circuits and voltage waveforms are shown in Section 1.



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